



H-mode pedestal measurements in NSTX

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Pedestal characterization

- Present diagnostics: MPTS, CHERS (core and edge),
- 1-D CCD camera neutral and impurity profiles at LCFS
- Need to study pedestal width and height dependence on B_p, T_e, T_i, A
- Edge localized modes
- In / out pedestal asymmetry
- HHFW and NBI heated H-mode plasmas

Proposed pedestal diagnostic

- High resolution filtered AXUV photodiode arrays with tangential views at inboard and outboard pedestal region
- Metal foil filter (e.g. Ti) measure C V, C VI profiles R = 125 - 150 cm, $T_e < 300 - 500 \text{ eV}, n_e < 3 \times 10^{13} \text{ cm}^{-3}$
- Interference FUV filter measure C IV profile
 R = 140 160 cm